

CIL
CRITICAL ITEMS LIST

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Date: 12/05/2011

12/24/91 SUPERSEDES 01/31/90

JWWN TS11

NAME	P/N	FAILURE MODE & CAUSES	FAILURE EFFECT	RATIONALE FOR ACCEPTANCE
CRIT				
EMI ELECTRICAL HARNESS, ITEM 460 SV787690-02 (1)	2/2	440FM04: Unable to latch CCA connector or disconnects. DANGER: Fracture-part structural failure of latch spring due to fatigue.	EMI ITEM: Unable to latch CCA connectors. GIE INTERFACE: Loss of all communication Functions if connector damaged. MISSION: Terminate EVA with loss of communication.	A. Design - The latches are machined out of 17-4 PH, condition #1075 stainless steel with a minimum tensile strength of 165 kpsi. They are attached to the connector housing with roll pins which have a rated load carrying capability of 100 lbs each. The springs used to hold the latches in position are formed from AISI 302 stainless steel wire that is work hardened to a minimum tensile strength of 125 kpsi. The latch spring loads the latch against the roll pins with a minimum force of 0.5 lbs. To ensure external loads will not cause disengagement, all moving parts are coated with a dry film lubricant to minimize friction and latch hangup. The latch system is designed so connectors can be mated without depressing the latches but cannot be demated without depressing both latches simultaneously. B. Test - Component Acceptance Test - The EEM is subjected to a connector interface test which mates the CCA and ECG connectors to their mating connector and subjects them to a pull test (10 pounds) to insure the latch mechanism will withstand a minimum load without disconnecting. PMA Test - Connector Interface Testing per DENU-60-010, Para. 3.1, verifies each connector's ability to latch properly by subjecting noted connector pair to a 6 in-lb torque applied to the body of the mated pair. Certification Test - The EEM completed the structural vibration and shock certification requirements during 19783. EC42806-212-1 (edded connector Interface check) has been incorporated and certified. C. Inspection - The EEM and CCA connector housings are inspected to insure the latch mechanism meets S/P dimensions. The ECG and CCA connector latch mechanisms are mated to mating connectors and pull tested during IPT to insure that they function as specified.

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NAME	FAILURE	CAUSES	FAILURE EFFECT	REASONABLE FOR ACCEPTANCE
P/N	MODE S			ANALYST:
QIT	CRIT			
2/2	440FM04:			

D. Failure History -
J-EMU-440-002 (5-10-85) During work of the harness, it was found that the ECO connector could not be properly mated with its interfacing connector. It was determined the latch on the connector did not meet vendor blue print dimensions.

The vendor revised his procedures to require 100% parts inspection. EC 42006-212 was issued which added the critical dimensions to the Hamilton Standard procurement drawing. In addition, EC 42006-212-1 was issued to add a rate/demate test to the EEN PDA. The ECO and CCA connectors use the same type of latching mechanism.
H-EMU-440-002 (12-6-83) During EEN Acceptance Testing, the ECO connector pulled away from its mating connector. Investigation at the vendor found that a pivot pin had been improperly installed, inhibiting proper movement of one of the latches. EC 42006-436 was issued to add a 10 lb. pull test of the mated connectors as a part of receiving inspection. The ECO and CCA connectors use the same type of latching mechanism.

J-EMU-440-003 (8-14-86) During preparations for a chamber run, the CCA connector would not remain latched to its CCA connector. The failure was caused by an improperly hardened latch spring. The spring had taken an excessive set and could not provide adequate retention force for the latch. The vendor added extra in-process testing to verify that the springs used are acceptable and Hamilton Standard added a side force test to the PDA to insure the connector would remain mated.

H-EMU-440-C002 (7-30-86) The ENU electrical harness failed open after a 1000 cycle tilt test. The cause of the failure was wicking of epoxy into the wires behind the connector during the encapsulation operation. EC 1832602-2 incorporates changes to prevent this problem and will track the configuration impact.

E. Ground Turnaround -
Tested per FEMU-N-001, SEMU Communications Check.

F. Operational Use -
Crew Response - PreEVA/EMU: Trouble shoot problem. If no success, discontinue use of ENU. Consider third EMU if

1000-414-262
1000-414-263

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ANALYST:

NAME	FAILURE		FAILURE EFFECT	RATIONALE FOR ACCEPTANCE
P/N	MODE &	CAUSES		
QTY	CRIT			
	2/2	448FM04:		available. Training - standard EHU training covers this mode. Operational Considerations - flight rules define go/no go criteria related to EHU minimum communications. EM checklist procedures verify hardware integrity and system operational status prior to EVS.